

**Search Notes**

Application/Control No.

10/519,923

Examiner

James D. Ewart

Applicant(s)/Patent under  
Reexamination

KROTH ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	449	10/6/2006	JDE
	452.2		
	453		
	507		
370	229		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR